Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/539,870	IWAKI ET AL.
Examiner	Art Unit

3643

Son T. Nguyen

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEAR		')
	DATE	EXMR
previous search updated	10/27/2007	STN